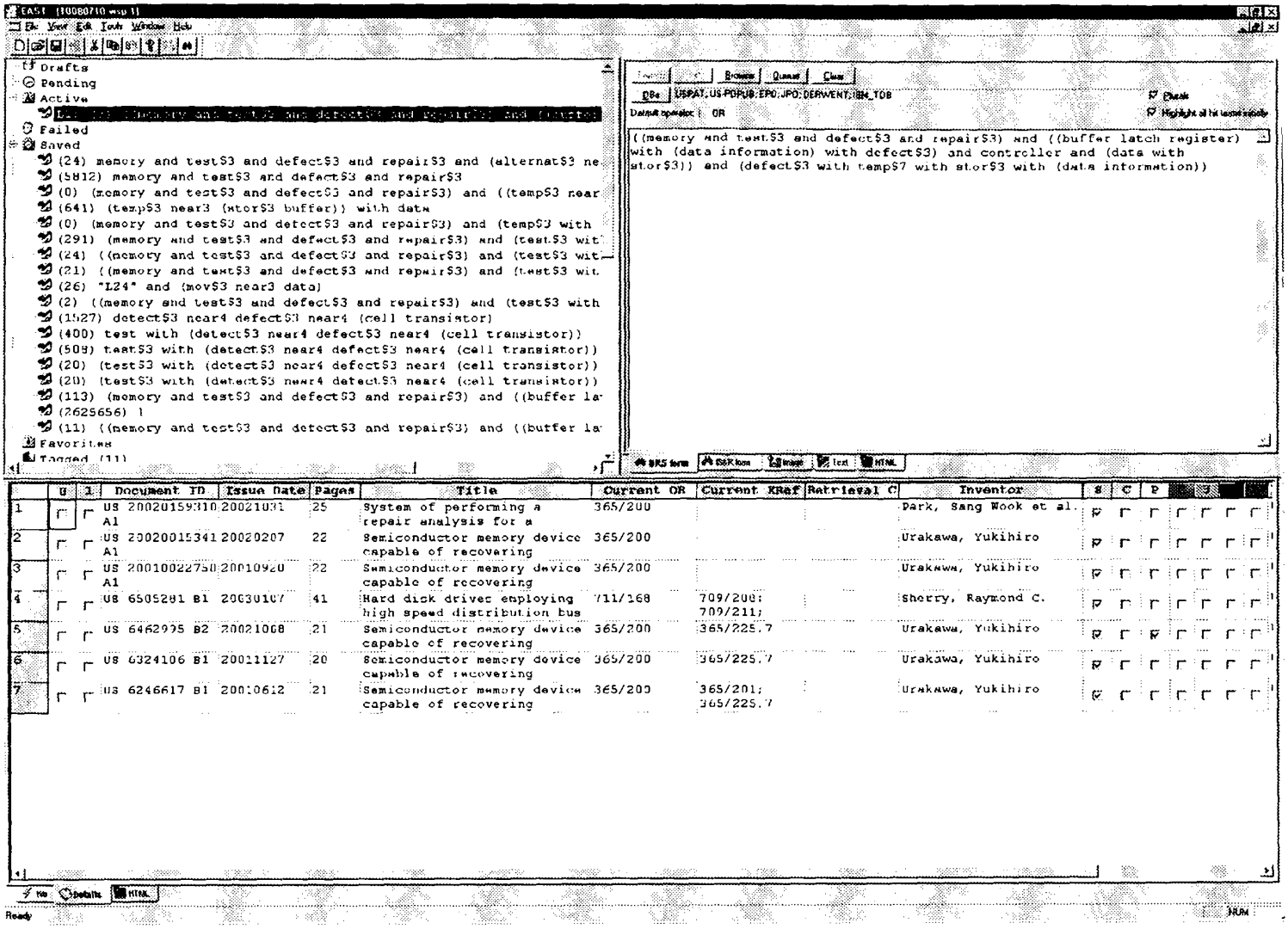
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(24) memory and test$3 and defect$3 and repair$3 and (alternat$3 ne
(5812) memory and test$3 and defect$3 and repair$3
(0) (memory and test$3 and defect$3 and repair$3) and ((temp$3 near
(641) (temp$3 near3 (stor$3 buffer)) with data
(0) (memory and test$3 and defect$3 and repair$3) and (temp$3 with
(291) (memory and test$3 and defect$3 and repair$3) and (test$3 wit
(24) ((memory and test$3 and defect$3 and repair$3) and (test$3 wit
(21) ((memory and test$3 and defect$3 and repair$3) and (test$3 wit
(26) "L24" and (mov$3 near3 data)
(2) ((memory and test$3 and defect$3 and repair$3) and (test$3 with
(1527) detect$3 near4 defect$3 near4 (cell transistor)
(400) test with (detect$3 near4 defect$3 near4 (cell transistor))
(509) test$3 with (detect$3 near4 defect$3 near4 (cell transistor))
(20) (test$3 with (detect$3 near4 defect$3 near4 (cell transistor))
(20) (test$3 with (detect$3 near4 detect$3 near4 (cell transistor))
(113) (memory and test$3 and defect$3 and repair$3) and ((buffer la
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(11) ((memory and test$3 and detect$3 and repair$3) and ((buffer la
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((memory and test$3 and defect$3 and repair$3) and ((buffer latch register) with (data information) with defect$3) and controller and (data with stor$3)) and (defect$3 with temp$7 with stor$3 with (data information))
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1 US 20020159310 A1 20021031 25 System of performing a repair analysis for a 365/200 Park, Sang Wook et al.
2 US 20020015341 A1 20020207 22 Semiconductor memory device capable of recovering 365/200 Urakawa, Yukihiro
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4 US 6505281 B1 20030107 41 Hard disk drives employing high speed distribution bus 711/168 709/208; 709/211; Sherry, Raymond C.
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6 US 6324106 B1 20011127 20 Semiconductor memory device capable of recovering 365/200 365/225.7 Urakawa, Yukihiro
7 US 6246617 B1 20010612 21 Semiconductor memory device capable of recovering 365/200 365/201; 365/225.7 Urakawa, Yukihiro
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